

[illegible]

Pablo N. Tran

2618

SEARCHED			
Class	Subclass	Date	Examiner
455	226.1	10/12/00	JR
	226.2		
	232.1		
	227		
	234.2		
	236.1		
	237.1		
	326		
	289-285		
	205		
	302		
	130		
	513		
	226.3		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
455	227	10/12/06	PJ
	234.2	↓	↓
	326		
	313		

[illegible]

Search Notes (continued)

Application/Control No.

10/099,626

Examiner

Pablo N. Tran

**Applicant(s)/Patent under
Reexamination**

SEPPINEN ET AL.

Art Unit

2618

SEARCHED

Class	Subclass	Date	Examiner
455	67.11	10/12/16	JP
	67.13		
	67.14		
375	211-216		
	224-226		
	343		
	346		
	327		
320	129		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
375	224	10/12/16	JP